Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/749,456	KIM ET AL.
Examiner	Art Unit
Khai M. Nauven	2687

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	435.3 435.2 435.1 422.1 432.1 432.3	12/21/2005	KŊ
455	433 434	12/21/2005	KN
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455	186.1	12/22/2005	KN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East (see attached)		KN .